

Notice of References Cited	Application/Control No. 10/573,113		Applicant(s)/Patent Under Reexamination SHIMIZU ET AL.	
	Examiner PATRICK J. CONNOLLY		Art Unit 2877	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,882,433 B2	04-2005	Marron et al.	356/512
*	B	US-6,992,778 B2	01-2006	Nahum, Michael	356/512
*	C	US-2006/0203859 A1	09-2006	Cable et al.	372/020
*	D	US-7,130,059 B2	10-2006	Marron, Joseph C.	356/512
*	E	US-2007/0268456 A1	11-2007	Ohbayshi et al.	351/246
*	F	US-2008/0024788 A1	01-2008	SHIMIZU et al.	356/497
*	G	US-2008/0031410 A1	02-2008	SHIMIZU et al.	378/021
*	H	US-7,400,410 B2	07-2008	Baker et al.	356/498
*	I	US-2008/0252901 A1	10-2008	Shimizu et al.	356/497
*	J	US-2009/0002713 A1	01-2009	Ohbayashi et al.	356/477
*	K	US-2009/0174931 A1	07-2009	Huber et al.	359/340
*	L	US-7,564,565 B2	07-2009	Shimizu et al.	356/497
*	M	US-2009/0273790 A1	11-2009	SHIMIZU et al.	356/495

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Zuyuan et al, "Synthesized optical coherence tomography for imaging of scattering objects by use of a stepwise frequency-modulated tunable laser diode" OPTICS LETTERS Vol. 24, No. 21. November 1 st 1999. pp. 1502-1504.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/573,113		Applicant(s)/Patent Under Reexamination SHIMIZU ET AL.	
	Examiner PATRICK J. CONNOLLY		Art Unit 2877	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,732,784 B2	06-2010	Shimizu et al.	250/393
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.